

# Search Notes



Application/Control No.

10/762,230

Examiner

Randall Chin

Applicant(s)/Patent under Reexamination

YAW, LARRY

Art Unit

1744

## SEARCHED

Class	Subclass	Date	Examiner
15	215		
15	229.11		
15	229.12		
15	229.13	8/22/2005	RC
UPDATED SEARCH 4/13/06 re			

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST, OCR, JPO, EPO, DERWENT		
Inventor name search	8/22/2005	RC